Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,698	WILLIAMS ET AL.
Examiner	Art Unit
David E. Bochna	3679

	SEARCHED		
Class	Subclass	Date	Examiner
<u> </u>			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated the previous search	2/3/2006	DB